## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/563,327	IMAI, AKIRA
Examiner	Art Unit
TAN Q. NGUYEN	3661

SEARCHED						
Class	Subclass	Date	Examiner			
701	1,2,300 301,205 206,207 213	8/14/2008	TN			
455	456.1					
340	435,436					
	903					

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PLUS SEARCH	8/15/2008	: TN	
EAST SEARCH	8/14/2008	TN TN	